

Notice of References Cited	Application/Control No. 10/728,868		Applicant(s)/Patent Under Reexamination SHEN ET AL.	
	Examiner Melvin Curtis Mayes		Art Unit 1734	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0106482	08-2002	Bourlier et al.	428/116
*	B	US-4,249,976	02-1981	Hudson, Gordon F.	156/286
*	C	US-5,034,256	07-1991	Santiso et al.	428/73
*	D	US-5,635,013	06-1997	Boi, Claude	156/285
*	E	US-6,429,157	08-2002	Kishi et al.	442/227
*	F	US-5,037,498	08-1991	Umeda, Katsuhiko	156/307.3
*	G	US-6,099,683	08-2000	Meier et al.	156/292
*	H	US-5,316,604	05-1994	Fell, Barry M.	156/82
*	I	US-6,890,401	05-2005	Bernetich, Karl R.	156/307.5
*	J	US-2005/0025929	02-2005	Smith et al.	428/073
*	K	US-2002/0079052	06-2002	Zhou et al.	156/307.7
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	6-190955	07-1994	JP	----	----
	O	0 512 646	11-1992	EP	----	----
	P	2 658 116	08-1991	FR	----	----
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.